

CONTENTS

CONTRIBUTORS	vii
PREFACE	ix
FUTURE CONTRIBUTIONS	xi

The Structure of Quasicrystals Studied by Atomic-Scale Observations of Transmission Electron Microscopy

KENJI HIRAGA

I. Introduction	2
II. Quasiperiodic Lattices	3
III. Experimental Procedures	20
IV. Electron Diffraction of Quasicrystals	22
V. High-Resolution Electron Microscopy Images of Quasicrystals	31
VI. Structure of Icosahedral Quasicrystals	36
VII. Structure of Decagonal Quasicrystals and Their Related Crystalline Phases	51
VIII. Concluding Remarks	80
References	81

Add-On Lens Attachments for the Scanning Electron Microscope

ANJAM KHURSHEED

I. Introduction	87
II. In-Lens Attachments	102
III. Single-Pole Lens Attachments	125
IV. Secondary Electron Energy Spectrometers	135
V. Multibore Objective Lenses	163
VI. Summary	170
References	170

Electron Holography of Long-Range Electrostatic Fields

G. MATTEUCCI, G. F. MISSIROLI, AND G. POZZI

I. Introduction	174
II. Electron-Specimen Interaction	177
III. Recording and Processing of Electron Holograms	196
IV. Charged Dielectric Spheres	212
V. $p-n$ Junctions	221

VI. Investigation of Charged Microtips	235
VII. Conclusions	242
VIII. Update	243
References	245

Digital Image-Processing Technology Useful for Scanning Electron Microscopy and Its Practical Applications

EISAKU OHO

I. Introduction	252
II. Proper Acquisition and Handling of SEM Images	253
III. Quality Improvement of SEM Images	264
IV. Image Measurement and Analysis	287
V. SEM Parameters Measurement	289
VI. Color SEM Images	303
VII. Automatic Focusing and Astigmatism Correction	312
VIII. Remote Control of the SEM	314
IX. Ultralow Magnification and Wide-Area Observation Using the Modern Montage Technique	317
X. Active Image Processing and Multimodal Microscopy	321
References	324

INDEX	329
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